


<b>Search Notes</b>  	<b>Application/Control No.</b>  10775531	<b>Applicant(s)/Patent Under Reexamination</b>  DIAS ET AL.
	<b>Examiner</b>  Chen, Qing	<b>Art Unit</b>  2191

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) -- See Search History Printout	3/27/2007	QC
717/124-135 (limited class search)	3/27/2007	QC
EAST Inventor Name Search and Assignee Search (US-PGPUB; USPAT) -- See Search History Printout	3/27/2007	QC
NPL Search (ACM) -- See Printout	3/29/2007	QC
PLUS Search	3/27/2007	QC
PALM Inventor Name Search	3/27/2007	QC

INTERFERENCE SEARCH			
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